Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/826,927	CRANDALL ET AL.
Examiner	Art Unit
Phuoc Tran	2624

	SEAD	CHED	
	JEAN	CIILD	
Class	Subclass	Date	Examiner
382	166, 238, 244	7/30/2007	РТ
358	426.14		
704	500		
			-

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
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